## $^{38}$ Si $\beta^-$ decay (63 ms) 2017Tr02

History									
Туре	Author	Citation	Literature Cutoff Date						
Full Evaluation	Jun Chen	NDS 152, 1 (2018)	30-Sep-2017						

Parent: <sup>38</sup>Si: E=0;  $J^{\pi}=0^+$ ;  $T_{1/2}=63$  ms 8;  $Q(\beta^-)=1045\times10^1$  13;  $\%\beta^-$  decay=100.0

<sup>38</sup>Si-T<sub>1/2</sub>: From fit to measured decay curve of  $\beta$ -implant correlations (2017Tr02). This value is adopted in Adopted Levels of <sup>38</sup>Si. <sup>38</sup>Si-Q( $\beta^{-}$ ): 10450 *130* (2017Wa10: AME-2016).

<sup>38</sup>Si- $\%\beta^-$  decay:  $\%\beta^-n=25$  10 for <sup>38</sup>Si decay (determined by 2017Tr02), from 100–(summed  $\beta$  feeding to the bound levels in <sup>38</sup>P). 2017Tr02: <sup>38</sup>Si was produced via <sup>9</sup>Be(<sup>48</sup>Ca,X) with E=140 MeV/nucleon <sup>48</sup>Ca beam from the cyclotron at NSCL on a 795

mg/cm<sup>2</sup> Be target. Fragments were separated using A1900 fragment separator and implanted into a 16×16 segmented planar Ge double-sided strip detector (GeDSSD) for timing and position of the implanted ions, and subsequent decays.  $\beta$ -delayed  $\gamma$  rays were detected with the SeGA array of 16 segmented Ge detectors. Measured E $\gamma$ , I $\gamma$ ,  $\gamma\gamma$ -coin, implant- $\beta$ (t). Deduced levels, J,  $\pi$ ,  $\beta$  feedings,  $\%\beta$ -n, log *ft* values, parent T<sub>1/2</sub>. Comparisons with shell-model calculations.

### <sup>38</sup>P Levels

E(level) <sup>†</sup>	J <sup>π</sup> ‡	Comments
0	$(2^{-})$	
1120? 2	$(1^{+})$	
1694 <i>1</i>	$1^{+}$	
1874 <i>1</i>	$1^{+}$	
3700+x		E(level): $x < Q(\beta^{-}) - S(n)(^{38}P) = 6750$ 150, where S(n)=3700 80 (2017Wa10).

<sup>†</sup> From E $\gamma$  values in 2017Tr02.

<sup>‡</sup> Proposed by 2017Tr02 based on shell-model prediction for ground state and allowed  $\beta$ -decay for bound levels. The same assignments were adopted in Adopted Levels.

## $\beta^{-}$ radiations

Branching deduced by 2017Tr02 from the net direct feeding to each bound level and the number of total correlated implants (2017Tr02), unless otherwise noted.

E(decay)	E(level)	Ιβ <sup>-‡</sup>	$\log ft^{\dagger}$	Comments	
$(3 \times 10^{3 \#} 3)$	3700+x	25 10		$I\beta^-$ : %β <sup>-</sup> n=25 10, from 100–(summed β feeding to the bound levels in <sup>38</sup> P) (2017Tr02).	
(8.58×10 <sup>3</sup> 13)	1874	51 8	4.01 10	av $E\beta = 4038\ 65$	
(8.76×10 <sup>3</sup> 13)	1694	17 5	4.53 15	av $E\beta$ =4127 65	
$(9.33 \times 10^3 \ 13)$	1120?	74	5.0 <i>3</i>	av E $\beta$ =4410 65	

<sup>†</sup> Deduced by the evaluator using the LOGFT code. Values are nearly the same in 2017Tr02 using a slightly different value of  $Q(\beta^{-})=10.50$  MeV 11.

<sup>‡</sup> Absolute intensity per 100 decays.

<sup>#</sup> Estimated for a range of levels.

#### ${}^{38}\text{Si}\,\beta^-$ decay (63 ms) 2017Tr02 (continued)

 $\gamma(^{38}\text{P})$ 

I $\gamma$  normalization: From %I( $\beta$  feeding to 1874 level)=51 8 and the 1874 level is deexcited only by 1874 $\gamma$  to ground state.

$E_{\gamma}^{\dagger}$	$I_{\gamma}^{\dagger\ddagger}$	E <sub>i</sub> (level)	$\mathbf{J}_i^{\pi}$	$\mathbf{E}_{f}$	$\mathbf{J}_{f}^{\pi}$
1120 <sup>#</sup> 2	14 8	1120?	$(1^+)$	0	$(2^{-})$
1694 <i>1</i>	34 9	1694	$1^+$	0	$(2^{-})$
1874 <i>1</i>	100	1874	$1^+$	0	$(2^{-})$

<sup>†</sup> From 2017Tr02.

 $^{\ddagger}$  For absolute intensity per 100 decays, multiply by 0.51 8.

<sup>#</sup> Placement of transition in the level scheme is uncertain.

#### <sup>38</sup>Si $\beta^-$ decay (63 ms) 2017Tr02

# Decay Scheme

Intensities:  $I_{\gamma}$  per 100 parent decays









